

V6 Reflectometer

Publications in 2015

<p>Paul, A.; Teichert, A.; Krist, T.; Steitz, R.: Substrate-stress-induced magnetic and nonmagnetic structural correlations in Fe/Si multilayers. Journal of Applied Crystallography 48 (2015), p. 1023-1033 doi:10.1107/S1600576715009942</p>
<p>Früh, J.; Rühm, A.; Möhwald, H.; Krastev, R.; Köhler, R.: Reflectometry on curved interfaces. Physica B - Condensed Matter 457 (2015), p. 202-211 doi:10.1016/j.physb.2014.08.030</p>
<p>Nestler, P.; Passvogel, M.; Ahrens, H.; Soltwedel, O.; Köhler, R.; Helm, C.A.: Branched Poly(ethylenimine) as Barrier Layer for Polyelectrolyte Diffusion in Multilayer Films. Macromolecules 48 (2015), p. 8546-8556 doi:10.1021/acs.macromol.5b01065</p>